

Examiner Signature	/Nurul Matin/	Date Considered	06/01/2007
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In place of PTO-1449 Form		U. S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(use as many sheets as necessary)</i>				Application Number	Not Yet Known
				Filing Date	December 2, 2004
				Applicant(s)	Johan Torsner, et al.
				Art Unit	Not Yet Known 2611
				Examiner Name	Not Yet Known Nurul Matin
SHEET	1	OF	1	Attorney Docket Number	P16904-US1

U. S. PATENT DOCUMENTS				
Examiner's Initials	Cite No.	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
/NM/	AA	2003007490 A1	01/09/2003	Yi, S.J. et al

FOREIGN PATENT DOCUMENTS					
Examiner's Initials	Cite No.	Foreign Patent Document (Country Code - Number - Kind)	Publication Date MM-DD-YYYY	Patentee or Applicant of Cited Document	Translation Y/N
/NM/	AB	EP 1276293 A2	01/15/2003	LG Electronics Inc	
/NM/	AC	WO 0156249 A1	08/02/2001	Telefonaktiebolaget LM Ericsson (publ)	
/NM/	AD	JP 2001 83860 A	06/30/2000	Fujitsu Ltd	

OTHER PRIOR ART		
Examiner's Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article, title of the item, date, page(s), volume- issue number(s), publisher, city/country where published
/NM/	AE	SA DA COSTA, C. ET AL, Sequence synchronization in the ATM adaption layer, Proceedings of the Mediterranean Electrotechnical Conference, 1991, 22-24 May 1991, pages 505-508, vol. 1. page 505, column 3, line 1, page 507, column 2, line 26
/NM/	AF	Patent Abstracts of Japan, vol. 2000, no 09, October 12, 2000
/NM/	AG	Swedish patent Office, International Search Report for PCT/SE/03/00866, dated August 19, 2003.

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